

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	547	(perform or performing or performed) near4 operation near4 circuit near8 (short or closed or damage or damaged or damaging or destroy or destroyed or destroying)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 10:35
L2	32	1 and (fuse or fused or fusible or fusing or antifuse or anti-fuse or anti-fused or antifused)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 10:12
L3	785	(438/129).CCLS.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/07/29 10:32
L4	16741	(second near (pad or pads or conductor or conductive or conducting or metal)) near8 (isolated or isolating or isolation or separate or separating or separated or apart or open or opening or opened)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 10:22
L5	15	("6108260") or ("6088282") or ("6087707") or ("5345110") or ("5331196") or ("5324681") or ("5241496") or ("5110754").PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/07/29 10:24
L6	6268	(program or programming or programmed) near4 (fuse or fused or antifuse or (fusible near link) or anti-fuse)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 10:27
L7	43	(antifuse near latch) or (AFUSE near LACTH)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 10:29
L8	33	6 and 7	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 10:29

L9	29454	(program or programmed or programming) near4 (v or voltage)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 10:33
L10	6413	(program or programmed or programming) near4 (fuse or fused or fusing or fusible or antifuse or anti-fuse or anti-fused)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 10:34
L11	2401	9 and 10	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 10:34
L12	1882	11 and transistor	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 10:34
L13	1321	12 and (short or closed or damage or damaged or damaging or destroy or destroyed or destroying)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 10:35
L14	291	13 and (bond\$6 or ball or paste or solder or soldering or soldered or bump)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 10:39
L15	0	"breakdown near voltage" near8 (bleed or bleeding or bleded or leak or leaked or leaking)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 10:36
L16	81938	(ball near (bond bonding bonded)) or (wire near (bond bonding bonded))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 10:39

L17	104	14 and 16	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 10:40
L18	68	17 and ((@ad<"20010830") or (@rlad<"20010830"))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 10:48
L21	5	(antifuse or "fusible link") same ("ball bond" or bond\$4) same (interconnect\$4 or brigd\$6 or connect\$4) and ASIC	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 10:52
L22	72	(antifuse or "fusible link") and ("ball bond" or bond\$4) same (interconnect\$4 or brigd\$6 or connect\$4) and ASIC	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 11:04
L23	29143	Micron.as.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 11:05
L24	100	voltage near6 (damage or damaging or damaged or short or shorted) near4 (second near circuit)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 11:06
L25	0	23 and 24	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 11:06
L26	2	23 and 1	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 11:07

L27	350	(second near conductor) same (second near circuit) same (separated or separating or separate or open or isolate or isolating or isolated)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 11:08
L28	0	23 and 27	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 11:08
L29	113	protection near4 (second adj circuit)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 11:09
L30	0	23 and 29	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 11:09
L31	1848	"ball bond"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 11:09
L32	136	31 same (short or shorting or shorted)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 11:09
L33	15	23 and 32	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 11:11
L34	257	Fogal.in.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 11:11

L35	18	34 and 31	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 11:12
L36	11452	Reynolds.in.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 11:12
L37	3	36 and 31	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 11:13
L38	980	Cowles.in.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 11:13
L39	2123	(short or shorting or shorted) near 8 (second near (conductor or circuit))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 11:14
L43	35	9 and 39	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 11:15
L44	15	38 and 9	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/29 11:16
L46	1873	(438/128).CCLS.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/07/29 11:31

L49	2	("6169331").PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/07/29 11:48
L51	785	(438/129).CCLS.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/07/29 12:07